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AOD3N60/AOU3N60

600V,2.5A N-Channel MOSFET

General Description

The AOD3N60 & AOU3N60 have been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low $R_{\mathrm{DS(on)}},\,C_{\mathrm{iss}}$ and C_{rss} along with guaranteed avalanche capability these parts can be adopted quickly into new and existing offline power supply designs.

Product Summary

 $\begin{array}{lll} V_{DS} & 700V@150\,{}^{\circ}{} C \\ I_{D} \; (at \; V_{GS} = 10V) & 2.5A \\ R_{DS(ON)} \; (at \; V_{GS} = 10V) & < 3.5\Omega \end{array}$

100% UIS Tested! 100% R_g Tested!



TO252
DPAK

Top View

Bottom View

Top View

Bottom View

G

AOD3N60

AOD3N60

AOU3N60

Absolute Maximum Ratings	T _A =25℃ unless otherwise noted
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Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	600	V	
Gate-Source Voltage		V_{GS}	±30	V	
Continuous Drain	T _C =25℃	1	2.5		
Current ^B T _C =100℃		I _D	1.6	A	
Pulsed Drain Current ^c		I _{DM}	8		
Avalanche Current ^C		I _{AR}	2	A	
Repetitive avalanche energy ^C		E _{AR}	60	mJ	
Single pulsed avalanche energy H		E _{AS}	120	mJ	
Peak diode recovery	dv/dt	dv/dt	5	V/ns	
	T _C =25℃	P _D	56.8	W	
Power Dissipation ^B	Derate above 25°C	L D	0.45	W/ °C	
Junction and Storage Temperature Range		T _J , T _{STG}	-50 to 150	°C	
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds		TL	300	C	

Thermal Characteristics						
Parameter	Symbol	Typical	Maximum	Units		
Maximum Junction-to-Ambient A,G	$R_{\theta JA}$	45	55			
Maximum Case-to-sink ^A	$R_{\theta CS}$	-	0.5	℃/W		
Maximum Junction-to-Case ^{D,F}	$R_{\theta JC}$	1.8	2.2	℃/W		



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC PARAMETERS							
Dynain Causes D	Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V, T_J=25^{\circ}C$	600				
DVDSS	BV _{DSS} Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V, T_J=150^{\circ}C$		700		V	
BV_{DSS} / ΔTJ	Zero Gate Voltage Drain Current	ID=250µA, VGS=0V		0.65		V/°C	
Inno	I _{DSS} Zero Gate Voltage Drain Current	V_{DS} =600V, V_{GS} =0V			1	μА	
DSS		V _{DS} =480V, T _J =125℃			10	μΑ	
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±30V			±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=5V I_{D}=250\mu A$	3	4	4.5	V	
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS}=10V, I_{D}=1.25A$		2.9	3.5	Ω	
g _{FS}	Forward Transconductance	V_{DS} =40V, I_{D} =1.25A		2.8		S	
V_{SD}	Diode Forward Voltage	$I_S=1A,V_{GS}=0V$		0.64	1	V	
Is	Maximum Body-Diode Continuous Current				2	Α	
I _{SM}	Maximum Body-Diode Pulsed Current				8	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance		240	304	370	рF	
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =25V, f=1MHz	25	31.4	38	pF	
C_{rss}	Reverse Transfer Capacitance		2.6	3.3	4	рF	
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz	2.3	2.9	6	Ω	
SWITCHI	SWITCHING PARAMETERS						
Q_g	Total Gate Charge			9.9	12	nC	
Q_{gs}	Gate Source Charge	V_{GS} =10V, V_{DS} =480V, I_{D} =2.5A		2.1	3	nC	
Q_{gd}	Gate Drain Charge			4.6	6	nC	
t _{D(on)}	Turn-On DelayTime			17	20	ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =300V, I_{D} =2.5A, R_{G} =25 Ω		17	20	ns	
t _{D(off)}	Turn-Off DelayTime			24	30	ns	
t _f	Turn-Off Fall Time			16	20	ns	
t _{rr}	Body Diode Reverse Recovery Time	$I_F=2.5A,dI/dt=100A/\mu s,V_{DS}=100V$		175	210	ns	
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=2.5A,dI/dt=100A/\mu s,V_{DS}=100V$		1.4	1.7	μС	

A. The value of R $_{\theta JA}$ is measured with the device in a still air environment with T $_A$ =25°C.

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B. The power dissipation P_D is based on $T_{J(MAX)}=150^{\circ}$ C in a TO252 package, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150$ °C.

D. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to case R $_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J_{i}MAX_{j}}$ =150°C.

G.These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C.

H. L=60mH, I_{AS}=2A, V_{DD}=150V, R_G=10 \odot , Starting T_J=25 $^{\circ}$ C



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 5: Break Down vs. Junction Temperature

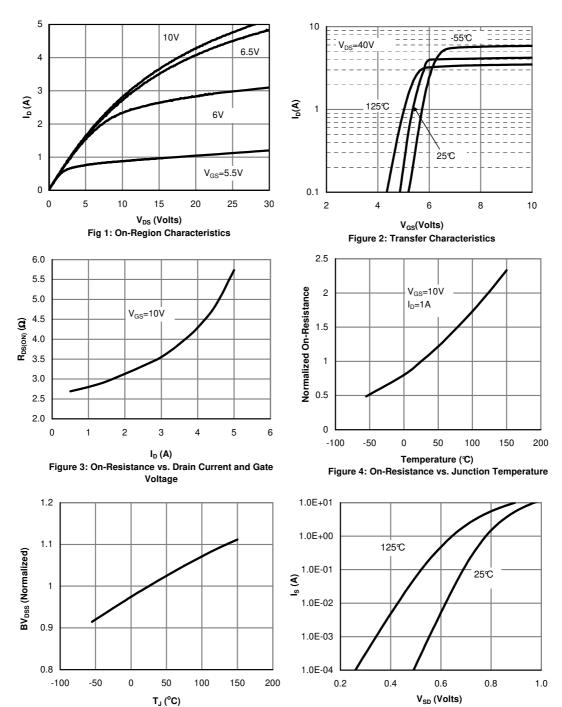


Figure 6: Body-Diode Characteristics

100

10



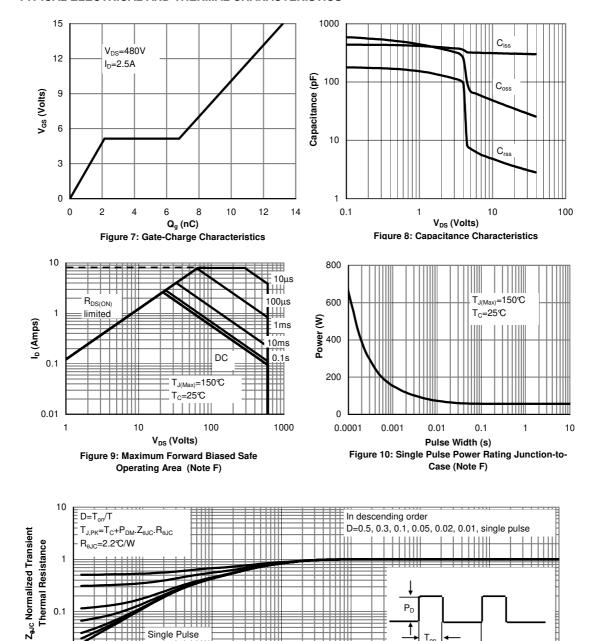
0.01

0.00001

0.0001

0.001

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

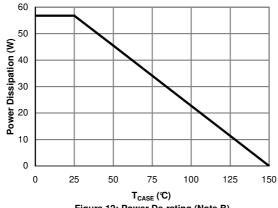
0.1

0.01

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



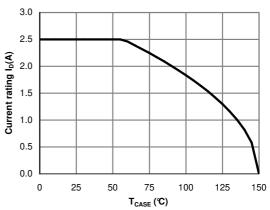


Figure 12: Power De-rating (Note B)

Figure 13: Current De-rating (Note B)

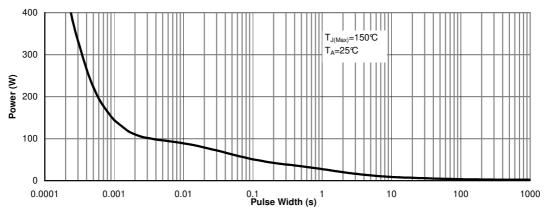


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note G)

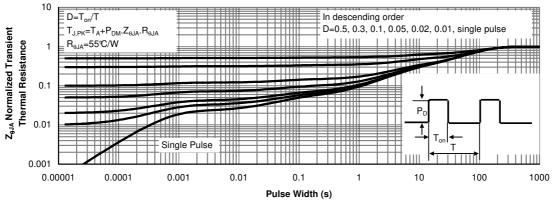
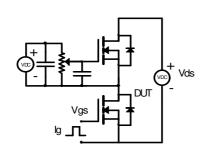


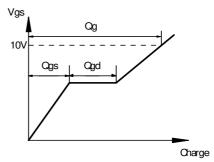
Figure 15: Normalized Maximum Transient Thermal Impedance (Note G)

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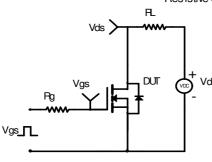


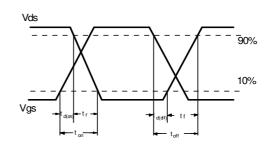
Gate Charge Test Circuit & Waveform



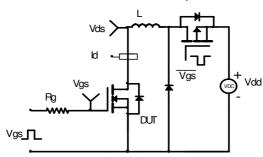


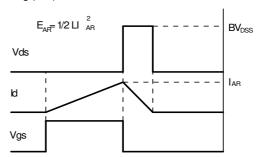
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

